

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-280001	Application No. 09/894,950
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR § 1.58(b))		Applicant Yamazaki, et al	REC'D/FILE'D Group Art Unit 2825 2891 JUL 28 2004	
		Filing Date June 27, 2001		

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	TECH Class	CENTER 2800 Subclass	Filing Date If Appropriate
CYME	AA	5,886,364	03/23/1999	Zhang	—	—	
CYME	AB	6,198,133 B1	03/06/2001	Yamazaki et al.	—	—	
CYME	AC	6,340,830 B1	01/22/2002	Takemura	—	—	
CYME	AD	6,392,255 B1	05/21/2002	Shibata et al.	—	—	
CYME	AE	6,583,472 B1	06/24/2003	Shibata et al.	—	—	
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
CYME	AL	EP 1 081 676 A1	03/07/2001	EUROPE	—	—	In English
CYME	AM	EP 1 087 438 A2	03/28/2001	EUROPE	—	—	In English
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
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Examiner Signature	Date Considered
<i>C. Luekert</i>	4-14-05
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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Information Disclosure Statement by Applicant <small>(Use several sheets if necessary)</small> <small>(37 CFR §1.98(b))</small>		Applicant Yamazaki, et al		Filing Date June 27, 2001	
				Group Art Unit 2891	

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Foreign Patent Documents or Published Foreign Patent Applications							
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							Yes No
CME	AI	07-130652	5/19/95	Japan	—	—	Abstract only
CME	AJ	08-078329	3/22/96	Japan	—	—	Abstract only
CME	AK	10-135468	5/22/98	Japan	—	—	Abstract only
CME	AL	10-135469	5/22/98	Japan	—	—	Abstract only
	AM						

Other Documents (include Author, Title, Date, and Place of Publication)		
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CME	AN	Yamazaki, et al., U.S. Patent Application Serial No. 09/797,186 (pending), filed March 2, 2001, "Semiconductor Device and Manufacturing Method Thereof", pp. 70 specification, pp. 26 claims (claims 80), pp. 1 abstract, Figs. 1-24, one table. (Attorney Docket No. 12732/018001)
CME	AO	Yamazaki, et al., U.S. Patent Application Serial No. 09/809,646 (pending), filed March 16, 2001, "Semiconductor Display Device and Manufacturing Method Thereof", pp. 57 specification, pp. 11 claims (claims 25), pp. 1 abstract, Figs. 1-23. (Attorney Docket No. 12732/021001)
	AP	
	AQ	

Examiner Signature <i>C. Euckast</i>	Date Considered <i>4-14-05</i>
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<i>O P E R A T I O N S</i> <i>JAN 19 2005</i> <i>U. S. PATENT & TRADEMARK OFFICE</i>		Applicant Yamazaki, et al	
		Filing Date June 27, 2001	Group Art Unit 2825 — 2891

Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>OME</i>	AA	5,079,606	01/07/1992	Yamamura et al.	<u>1</u>	<u>1</u>	01/19/1990
	AB	5,605,847	02/25/1997	Zhang	<u>1</u>	<u>1</u>	06/02/1995
	AC	5,643,801	07/01/1997	Ishihara et al.	<u>1</u>	<u>1</u>	08/04/1995
	AD	5,886,364	03/23/1999	Zhang	<u>1</u>	<u>1</u>	07/03/1997
	AE	5,891,764	04/06/1999	Ishihara et al.	<u>1</u>	<u>1</u>	10/30/1996
	AF	6,243,155 B1	06/05/2001	Zhang et al.	<u>1</u>	<u>1</u>	10/19/1998
	AG	6,335,540 B1	01/01/2002	Zhang	<u>1</u>	<u>1</u>	02/18/1999
	AH	6,462,806 B2	10/08/2002	Zhang et al.	<u>1</u>	<u>1</u>	12/29/2000
	AI	6,555,420 B1	04/29/2003	Yamazaki	<u>1</u>	<u>1</u>	08/27/1999
	AJ	6,573,589 B2	06/03/2003	Zhang	<u>1</u>	<u>1</u>	12/20/2001
	AK	6,638,800 B1	10/28/2003	Ishihara et al.	<u>1</u>	<u>1</u>	10/01/1999
<i>OME</i>	AL	6,740,938 B2	05/25/2004	Tsunoda et al.	<u>1</u>	<u>1</u>	04/10/2002

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